

Notice of References Cited	Application/Control No. 10/021,205		Applicant(s)/Patent Under Reexamination CARVEY ET AL.	
	Examiner Andrew C. Lee		Art Unit 2476	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,073,176	06-2000	Baindur et al.	709/227
*	B	US-6,370,560	04-2002	Robertazzi et al.	718/105
*	C	US-5,115,495	05-1992	Tsuchiya et al.	709/239
*	D	US-6,819,670	11-2004	Fenner, Peter R.	370/392
*	E	US-5,095,480	03-1992	Fenner, Peter R.	370/238
*	F	US-6,195,354	02-2001	Skalecki et al.	370/395.32
*	G	US-6,160,818	12-2000	Berger et al.	370/468
*	H	US-5,848,055	12-1998	Fedyk et al.	370/228
*	I	US-2004/0037278	02-2004	Wong et al.	370/389
*	J	US-6,262,974	07-2001	Chevalier et al.	370/232
*	K	US-5,347,511	09-1994	Gun, Levent	370/255
*	L	US-5,233,604	08-1993	Ahmadi et al.	370/238
*	M	US-6,580,715	06-2003	Bare, Ballard C.	370/396

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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